Application/Control No. Applicant(s)/Patent Under Reexamination 10/696,402 HARDESTY ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1742 Deborah Yee **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 219/146.22 US-5,124,529 06-1992 Nishikawa et al. Α US-В C US-US-D US-E US-F US-G US-Н US-US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

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